

Rev.02 - 27 December 2022

Product data sheet

1. General description

Planar passivated high commutation three quadrant triac in a TO220F "full pack" plastic package. This "series E" triac balances the requirements of commutation performance and gate sensitivity and is intended for interfacing with low power drivers including microcontrollers.

2. Features and benefits

- 3Q technology for improved noise immunity
- · Direct interfacing with low power drivers and microcontrollers
- · Good immunity to false turn-on by dV/dt
- · High commutation capability with sensitive gate
- High voltage capability
- Isolated mounting base package
- Sensitive gate for easy logic level triggering
- Triggering in three quadrants only

3. Applications

- Electronic thermostats (heating and cooling)
- · High power motor controls e.g. washing machines and vacuum cleaners

4. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|--------------------------------|--|---|-----|-----|-----|------|
| Absolute | maximum rating | | | | | |
| V_{DRM} | repetitive peak off-state voltage | | - | - | 800 | V |
| $\mathbf{I}_{\mathrm{T(RMS)}}$ | RMS on-state current | full sine wave; T _h ≤ 59 °C; <u>Fig. 1; Fig. 2; Fig. 3</u> | - | - | 12 | A |
| I _{TSM} | non-repetitive peak on- state current | full sine wave; T _{j(init)} = 25 °C; t _p = 20 ms; <u>Fig. 4; Fig. 5</u> | - | - | 100 | A |
| | | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 16.7 ms | - | - | 110 | А |
| Tj | junction temperature | | - | - | 125 | °C |
| Static ch | aracteristics | · | | | | |
| I _{GT} gate | gate trigger current | V _D = 12 V; I _T = 0.1 A; T2+ G+; T _j = 25 °C; <u>Fig. 7</u> | - | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2+ G-; T _j = 25 °C; <u>Fig. 7</u> | - | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 7</u> | - | - | 10 | mA |

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|--|--|-----|-----|-----|------|
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 15 | mA |
| V _T | on-state voltage | I _T = 15 A; T _j = 25 °C; <u>Fig. 10</u> | - | 1.3 | 1.6 | V |
| Dynamic | characteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T _j = 125 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit | 50 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | $V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 12 \text{ A};$ $dV_{com}/dt = 20 \text{ V}/\mu \text{s}; \text{ (snubberless condition); gate open circuit}$ | 3 | - | - | A/ms |
| | | $V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 12 \text{ A};$ $dV_{com}/dt = 10 \text{ V}/\mu s;$ gate open circuit | 6 | - | - | A/ms |
| | | $V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 12 \text{ A}; $ dV _{com} /dt = 1 V/µs; gate open circuit | 10 | - | - | A/ms |

5. Pinning information

| Table 2. | Pinning info | rmation | | |
|----------|---------------------|-------------------------|--------------------|----------------|
| Pin | Symbol | Description | Simplified outline | Graphic symbol |
| 1 | T1 | main terminal 1 | mb | N 1 |
| 2 | T2 | main terminal 2 | | T2-T1 |
| 3 | G | gate | | Sym051 |
| mb | n.c. | mounting base; isolated | | |

6. Ordering information

| Table 3. Ordering information | | | | | | | |
|-------------------------------|-----------------|-----------------------|----------------|---------------------------|-----------------|-----------------------|--|
| Type number | Package Name | Orderable part number | Packing method | Small packing quantity | Package version | Package issue date | |
| BTA312X-800E | TO220F | BTA312X-800E,127 | Tube | 50 | SOT186A | 14-Nov-2013 | |

7. Marking

Table 4. Marking codes

| Type number | Marking codes | | |
|--------------|-------------------------------|-------------------------------|--|
| | Assembly factory: d | Assembly factory: A | |
| BTA312X-800E | BTA312X 800E PJdxxxx xx | BTA312X 800E PJAxxxx xx | |

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Mi | in M | ax | Unit |
|---------------------|--|---|----|------|----|------------------|
| V_{DRM} | repetitive peak off-state voltage | | - | 80 | 00 | V |
| I _{T(RMS)} | RMS on-state current | full sine wave; T _h ≤ 59 °C; Fig 1; Fig 2; Fig 3 | - | 12 | 2 | A |
| I _{TSM} | non-repetitive peak on- state current | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 20 ms; Fig 4; Fig 5 | - | 1(| 00 | A |
| | | full sine wave; $T_{j(init)}$ = 25 °C; t_p = 16.7 ms | - | 11 | 10 | А |
| l ² t | I ² t for fusing | t _p = 10 ms; SIN | - | 50 |) | A ² s |
| dl⊤/dt | rate of rise of on-state current | I _G = 0.2 A | - | 1(| 00 | A/µs |
| I _{GM} | peak gate current | | - | 2 | | А |
| P_{GM} | peak gate power | | - | 5 | | W |
| P _{G(AV)} | average gate power | over any 20 ms period | - | 0. | 5 | W |
| T _{stg} | storage temperature | | -4 | 0 18 | 50 | °C |
| Tj | junction temperature | | - | 12 | 25 | °C |

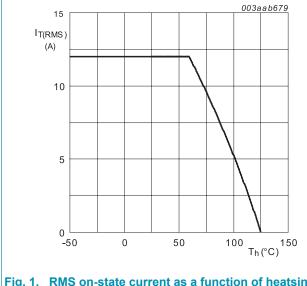
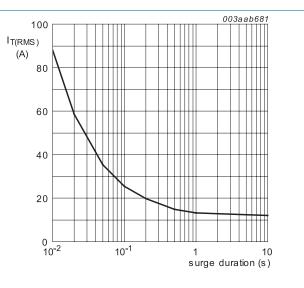
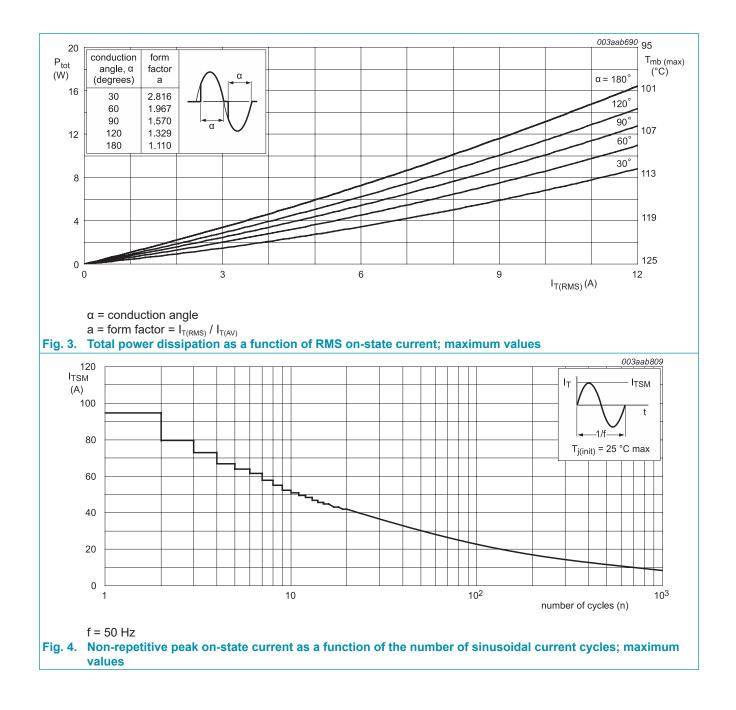
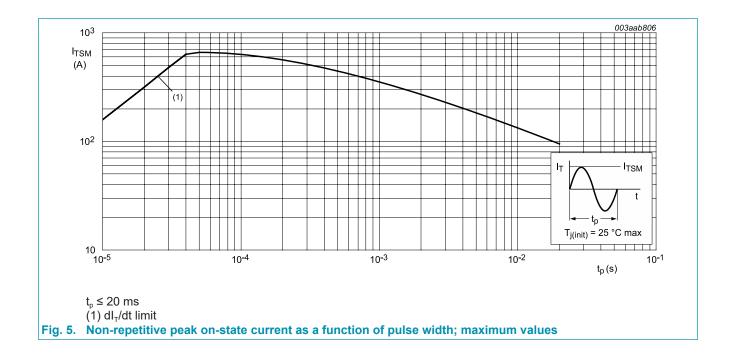


Fig. 1. RMS on-state current as a function of heatsink temperature; maximum values



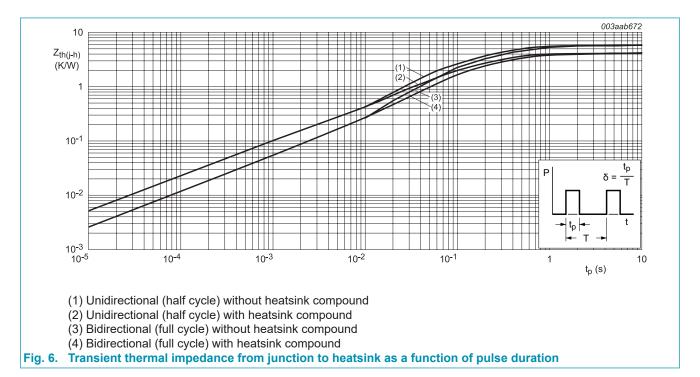






9. Thermal characteristics

| Table 6. Th | ermal characteristics | | | | | |
|----------------------|---|--|-----|-----|-----|------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
| R _{th(j-h)} | thermal resistance from junction to | full cycle or half cycle; with heatsink compound; Fig 6 | - | - | 4 | K/W |
| | heatsink | full cycle or half cycle; without heatsink compound; Fig 6 | - | - | 5.5 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | in free air | - | 55 | - | K/W |

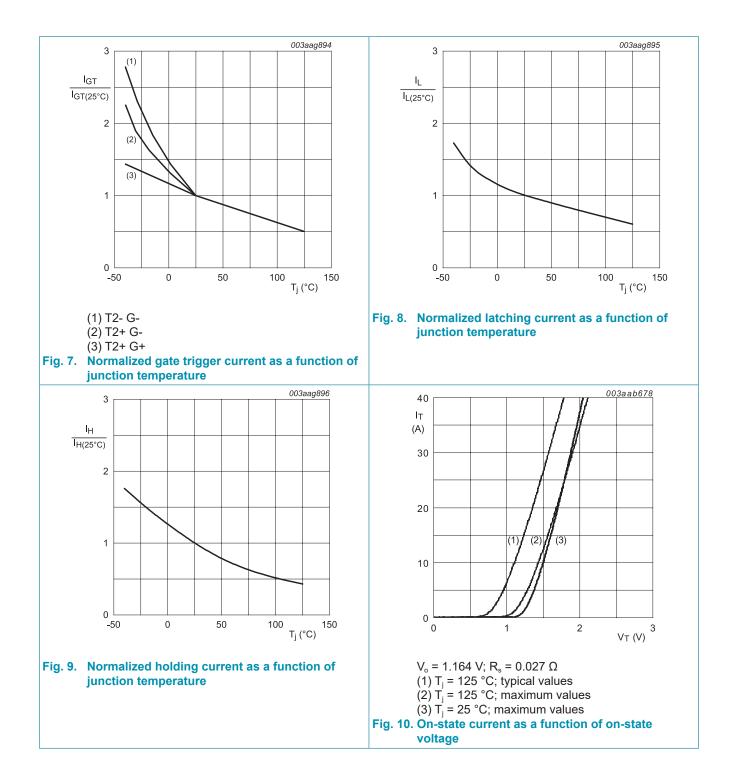


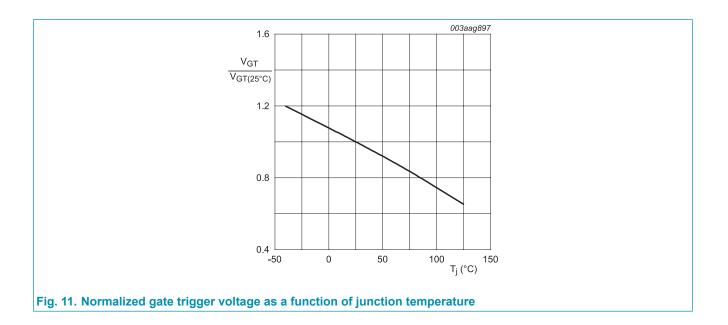
10. Isolation characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|-----------------------|---|-----|-----|------|------|
| V _{isol(RMS)} | RMS isolation voltage | from all terminals to external heatsink; sinusoidal waveform; clean and dust free; 50 Hz \leq f \leq 60 Hz; RH \leq 65 %; T _h = 25 °C | - | - | 2500 | V |
| C _{isol} | isolation capacitance | from main terminal 2 to external heatsink; f = 1 MHz; $T_h = 25 ^{\circ}\text{C}$ | - | 10 | - | pF |

11. Characteristics

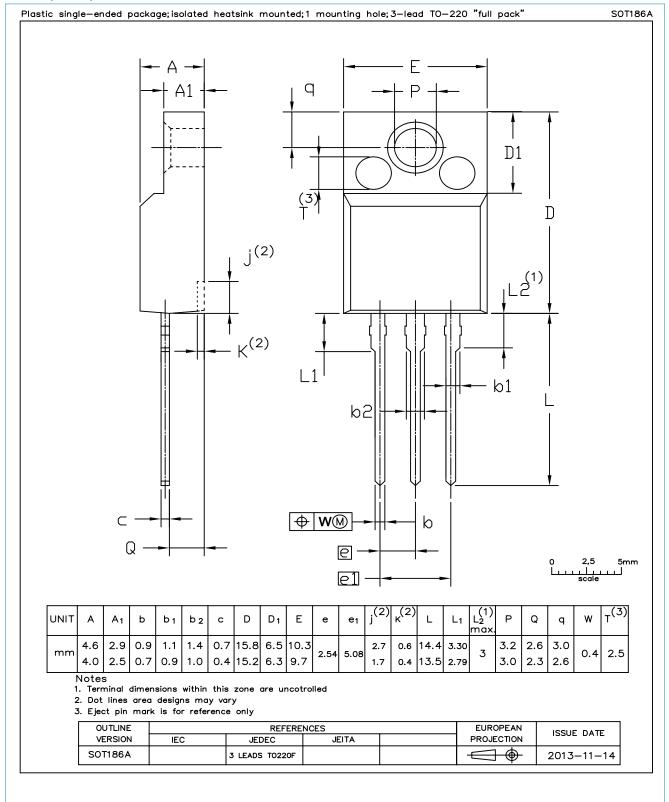
| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-----------------------|--|--|------|-----|-----|------|
| Static cha | racteristics | · | | | | |
| I _{GT} | gate trigger current | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G+};$ $\text{T}_{j} = 25 ^{\circ}\text{C}; \text{ Fig. 7}$ | - | - | 10 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G-};$ T _j = 25 °C; Fig. 7 | - | - | 10 | mA |
| | | V _D = 12 V; I _T = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 7</u> | - | - | 10 | mA |
| I _L | latching current | $V_{D} = 12 \text{ V}; \text{ I}_{G} = 0.1 \text{ A}; \text{ T2+ G+};$ $\text{T}_{j} = 25 ^{\circ}\text{C}; \text{ Fig. 8}$ | - | - | 25 | mA |
| | | $V_{D} = 12 \text{ V}; \text{ I}_{G} = 0.1 \text{ A}; \text{ T2+ G-};$ T _j = 25 °C; Fig. 8 | - | - | 30 | mA |
| | | V _D = 12 V; I _G = 0.1 A; T2- G-; T _j = 25 °C; <u>Fig. 8</u> | - | - | 25 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | - | 15 | mA |
| V _T | on-state voltage | I _τ = 15 A; T _j = 25 °C; <u>Fig. 10</u> | - | 1.3 | 1.6 | V |
| V _{GT} gat | gate trigger voltage | $V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T}_{j} = 25 \text{ °C};$ Fig. 11 | - | 0.7 | 1 | V |
| | | V _D = 400 V; I _T = 0.1 A; T _j = 125 °C | 0.25 | 0.4 | - | V |
| I _D | off-state current | V _D = 800 V; T _j = 125 °C | - | 0.1 | 0.5 | mA |
| Dynamic | characteristics | 1 | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 536 V; T _j = 125 °C; (V_{DM} = 67% of V_{DRM}); exponential waveform; gate open circuit | 50 | - | - | V/µs |
| dl _{com} /dt | rate of change of commutating current | $V_{D} = 400 \text{ V}; \text{ T}_{j} = 125 \text{ °C}; \text{ I}_{T(RMS)} = 12 \text{ A}; $ $dV_{com}/dt = 20 \text{ V}/\mu\text{s}; \text{ (snubberless condition); gate open circuit}$ | 3 | - | - | A/ms |
| | | V_D = 400 V; T _j = 125 °C; I _{T(RMS)} = 12 A; dV _{com} /dt = 10 V/µs; gate open circuit | 6 | - | - | A/ms |
| | | V_D = 400 V; T _j = 125 °C; I _{T(RMS)} = 12 A; dV _{com} /dt = 1 V/µs; gate open circuit | 10 | - | - | A/ms |





12. Package outline

Assembly factory: d & A



BTA312X-800E
Product data sheet

13. Legal information

Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|-----------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

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- [2] The term 'short data sheet' is explained in section "Definitions".
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